

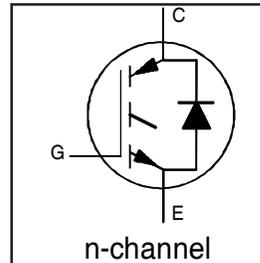
IRG4BC20KD-SPbF

INSULATED GATE BIPOLAR TRANSISTOR WITH ULTRAFAST SOFT RECOVERY DIODE

Short Circuit Rated
 UltraFast IGBT

Features

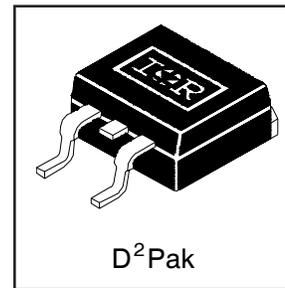
- Short Circuit Rated UltraFast: Optimized for high operating frequencies >5.0 kHz , and Short Circuit Rated to 10μs @ 125°C, $V_{GE} = 15V$
- Generation 4 IGBT design provides tighter parameter distribution and higher efficiency than previous generation
- IGBT co-packaged with HEXFRED™ ultrafast, ultra-soft-recovery anti-parallel diodes for use in bridge configurations
- Industry standard D²Pak package
- Lead-Free



$V_{CES} = 600V$
 $V_{CE(on)} \text{ typ.} = 2.27V$
 @ $V_{GE} = 15V, I_C = 9.0A$

Benefits

- Latest generation 4 IGBT's offer highest power density motor controls possible.
- HEXFRED™ diodes optimized for performance with IGBTs. Minimized recovery characteristics reduce noise, EMI and switching losses.
- This part replaces the IRGBC20KD2-S and IRGBC20MD2-S products.
- For hints see design tip 97003.



Absolute Maximum Ratings

| | Parameter | Max. | Units |
|---------------------------|--|---------------------|-------|
| V_{CES} | Collector-to-Emitter Voltage | 600 | V |
| $I_C @ T_C = 25^\circ C$ | Continuous Collector Current | 16 | A |
| $I_C @ T_C = 100^\circ C$ | Continuous Collector Current | 9.0 | |
| I_{CM} | Pulsed Collector Current ① | 32 | |
| I_{LM} | Clamped Inductive Load Current ② | 32 | |
| $I_F @ T_C = 100^\circ C$ | Diode Continuous Forward Current | 7.0 | |
| I_{FM} | Diode Maximum Forward Current | 32 | μs |
| t_{sc} | Short Circuit Withstand Time | 10 | |
| V_{GE} | Gate-to-Emitter Voltage | ± 20 | V |
| $P_D @ T_C = 25^\circ C$ | Maximum Power Dissipation | 60 | W |
| $P_D @ T_C = 100^\circ C$ | Maximum Power Dissipation | 24 | |
| T_J | Operating Junction and Storage Temperature Range | -55 to +150 | °C |
| T_{STG} | | | |
| | | | |
| | Mounting Torque, 6-32 or M3 Screw. | 10 lbf•in (1.1 N•m) | |

Thermal Resistance

| | Parameter | Typ. | Max. | Units |
|-----------------|---|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case - IGBT | --- | 2.1 | °C/W |
| $R_{\theta JC}$ | Junction-to-Case - Diode | --- | 2.5 | |
| $R_{\theta CS}$ | Case-to-Sink, Flat, Greased Surface | 0.5 | --- | |
| $R_{\theta JA}$ | Junction-to-Ambient (PCB Mounted, steady-state)③ | --- | 40 | |
| Wt | Weight | 1.44 | --- | g |

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Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions | |
|---------------------------------|---|------|------|-----------|----------------------|---|----------------|
| $V_{(BR)CES}$ | Collector-to-Emitter Breakdown Voltage ^③ | 600 | — | — | V | $V_{GE} = 0V, I_C = 250\mu A$ | |
| $\Delta V_{(BR)CES}/\Delta T_J$ | Temperature Coeff. of Breakdown Voltage | — | 0.49 | — | V/ $^\circ\text{C}$ | $V_{GE} = 0V, I_C = 1.0mA$ | |
| $V_{CE(on)}$ | Collector-to-Emitter Saturation Voltage | — | 2.27 | 2.8 | V | $I_C = 9.0A$ $I_C = 16A$ $I_C = 9.0A, T_J = 150^\circ\text{C}$ | |
| | | — | 3.01 | — | | | $V_{GE} = 15V$ |
| | | — | 2.43 | — | | | See Fig. 2, 5 |
| $V_{GE(th)}$ | Gate Threshold Voltage | 3.0 | — | 6.0 | | $V_{CE} = V_{GE}, I_C = 250\mu A$ | |
| $\Delta V_{GE(th)}/\Delta T_J$ | Temperature Coeff. of Threshold Voltage | — | -10 | — | mV/ $^\circ\text{C}$ | $V_{CE} = V_{GE}, I_C = 250\mu A$ | |
| g_{fe} | Forward Transconductance ^④ | 2.9 | 4.3 | — | S | $V_{CE} = 100V, I_C = 9.0A$ | |
| I_{CES} | Zero Gate Voltage Collector Current | — | — | 250 | μA | $V_{GE} = 0V, V_{CE} = 600V$ $V_{GE} = 0V, V_{CE} = 600V, T_J = 150^\circ\text{C}$ | |
| | | — | — | 1000 | | | |
| V_{FM} | Diode Forward Voltage Drop | — | 1.4 | 1.7 | V | $I_C = 8.0A$ $I_C = 8.0A, T_J = 150^\circ\text{C}$ | |
| | | — | 1.3 | 1.6 | | | See Fig. 13 |
| I_{GES} | Gate-to-Emitter Leakage Current | — | — | ± 100 | nA | $V_{GE} = \pm 20V$ | |

Switching Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|------------------|--|------|------|------|------------|---|
| Q_g | Total Gate Charge (turn-on) | — | 34 | 51 | nC | $I_C = 9.0A$ $V_{CC} = 400V$ $V_{GE} = 15V$ See Fig. 8 |
| Q_{ge} | Gate - Emitter Charge (turn-on) | — | 4.9 | 7.4 | | |
| Q_{gc} | Gate - Collector Charge (turn-on) | — | 14 | 21 | | |
| $t_{d(on)}$ | Turn-On Delay Time | — | 54 | — | ns | $T_J = 25^\circ\text{C}$ $I_C = 9.0A, V_{CC} = 480V$ $V_{GE} = 15V, R_G = 50\Omega$ |
| t_r | Rise Time | — | 34 | — | | |
| $t_{d(off)}$ | Turn-Off Delay Time | — | 180 | 270 | | |
| t_f | Fall Time | — | 72 | 110 | | |
| E_{on} | Turn-On Switching Loss | — | 0.34 | — | mJ | Energy losses include "tail" and diode reverse recovery See Fig. 9,10,14 |
| E_{off} | Turn-Off Switching Loss | — | 0.30 | — | | |
| E_{ts} | Total Switching Loss | — | 0.64 | 0.96 | | |
| t_{sc} | Short Circuit Withstand Time | 10 | — | — | μs | $V_{CC} = 360V, T_J = 125^\circ\text{C}$ $V_{GE} = 15V, R_G = 50\Omega, V_{CPK} < 500V$ |
| $t_{d(on)}$ | Turn-On Delay Time | — | 51 | — | ns | $T_J = 150^\circ\text{C}$, See Fig. 11,14 $I_C = 9.0A, V_{CC} = 480V$ $V_{GE} = 15V, R_G = 50\Omega$ |
| t_r | Rise Time | — | 37 | — | | |
| $t_{d(off)}$ | Turn-Off Delay Time | — | 220 | — | | |
| t_f | Fall Time | — | 160 | — | | |
| E_{ts} | Total Switching Loss | — | 0.85 | — | mJ | Energy losses include "tail" and diode reverse recovery |
| L_E | Internal Emitter Inductance | — | 7.5 | — | nH | Measured 5mm from package |
| C_{ies} | Input Capacitance | — | 450 | — | pF | $V_{GE} = 0V$ $V_{CC} = 30V$ $f = 1.0MHz$ See Fig. 7 |
| C_{oes} | Output Capacitance | — | 61 | — | | |
| C_{res} | Reverse Transfer Capacitance | — | 14 | — | | |
| t_{rr} | Diode Reverse Recovery Time | — | 37 | 55 | ns | $T_J = 25^\circ\text{C}$ See Fig. 14 $T_J = 125^\circ\text{C}$ 14 |
| | | — | 55 | 90 | | |
| I_{rr} | Diode Peak Reverse Recovery Current | — | 3.5 | 5.0 | A | $T_J = 25^\circ\text{C}$ See Fig. 15 $T_J = 125^\circ\text{C}$ 15 |
| | | — | 4.5 | 8.0 | | |
| Q_{rr} | Diode Reverse Recovery Charge | — | 65 | 138 | nC | $T_J = 25^\circ\text{C}$ See Fig. 16 $T_J = 125^\circ\text{C}$ 16 |
| | | — | 124 | 360 | | |
| $di_{(rec)M}/dt$ | Diode Peak Rate of Fall of Recovery During t_b | — | 240 | — | A/ μs | $T_J = 25^\circ\text{C}$ See Fig. 17 $T_J = 125^\circ\text{C}$ 17 |
| | | — | 210 | — | | |

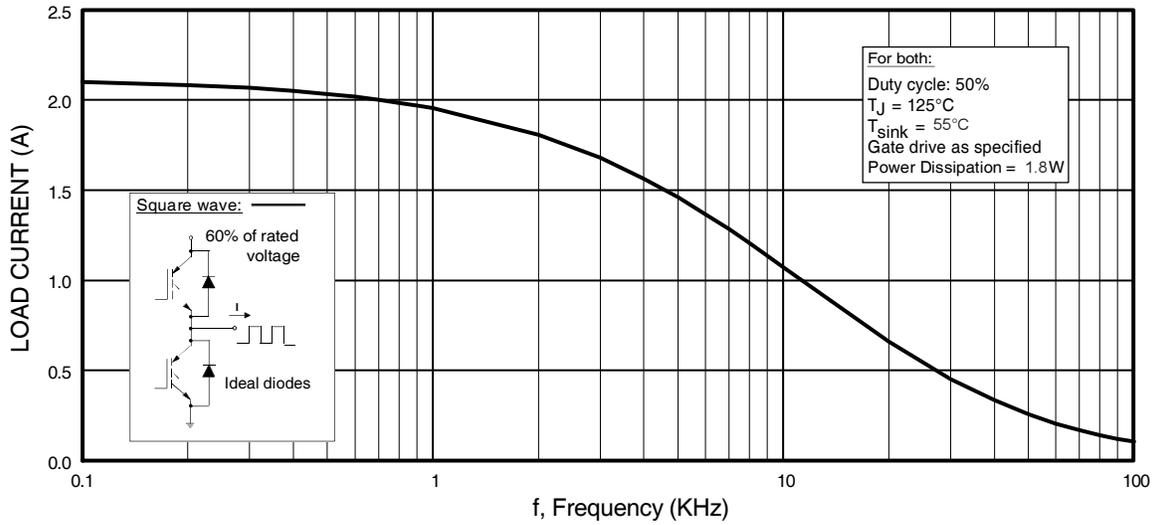


Fig. 1 - Typical Load Current vs. Frequency
 (Load Current = I_{RMS} of fundamental)

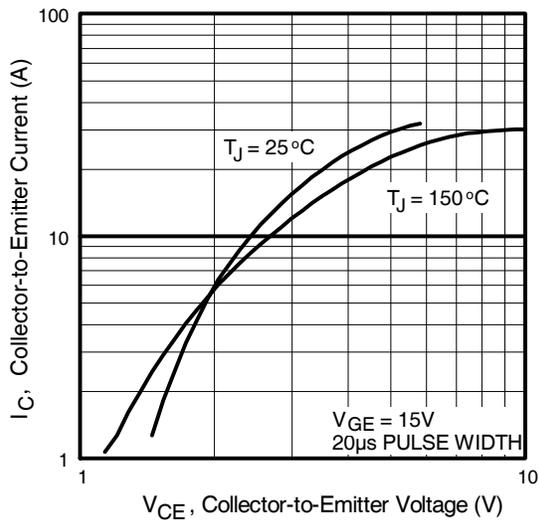


Fig. 2 - Typical Output Characteristics

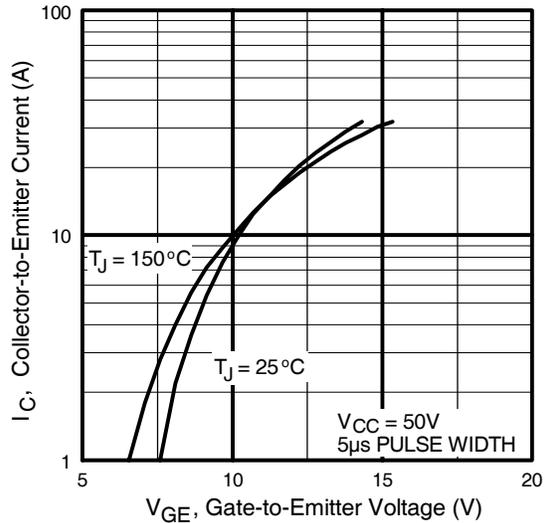


Fig. 3 - Typical Transfer Characteristics

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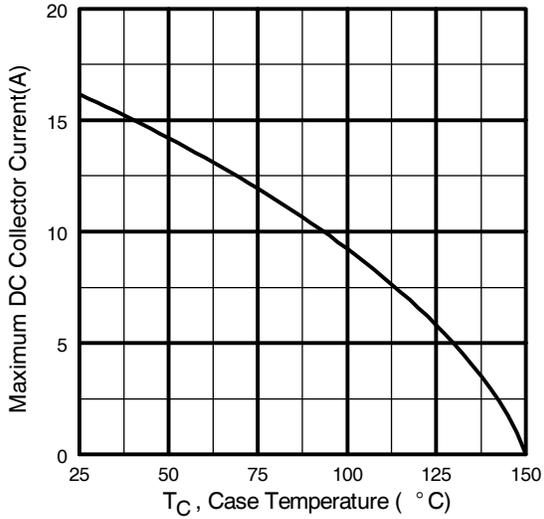


Fig. 4 - Maximum Collector Current vs. Case Temperature

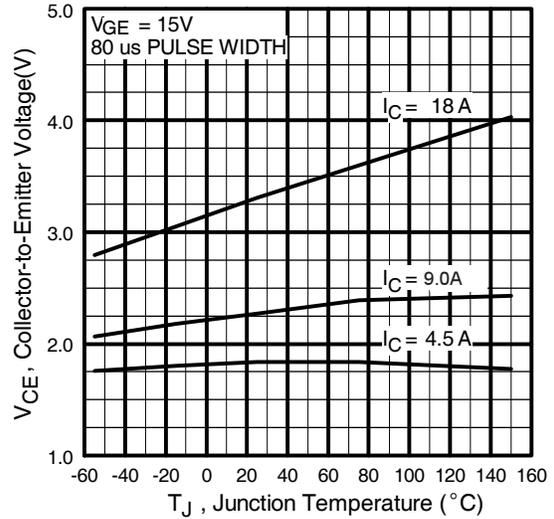


Fig. 5 - Typical Collector-to-Emitter Voltage vs. Junction Temperature

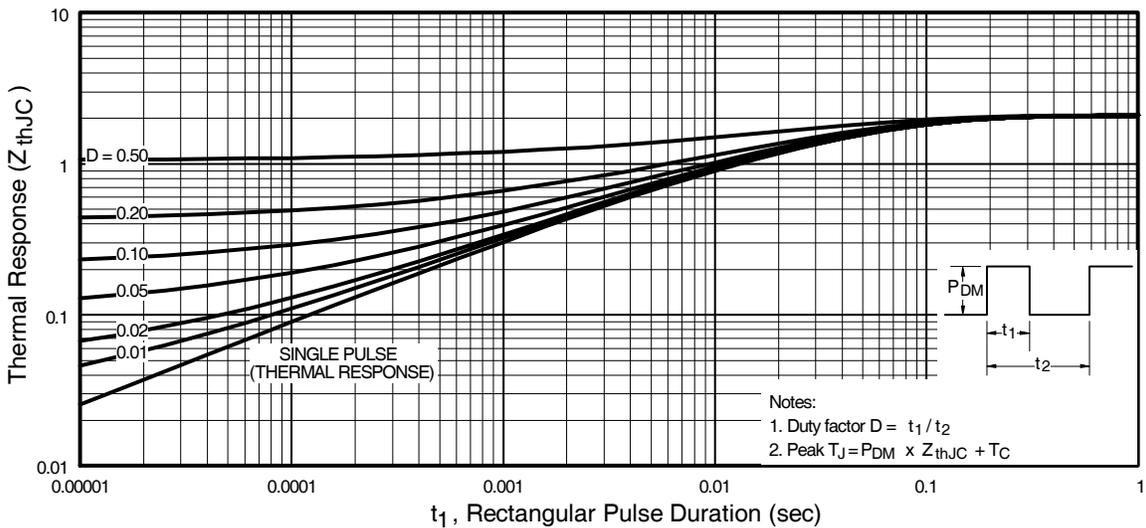


Fig. 6 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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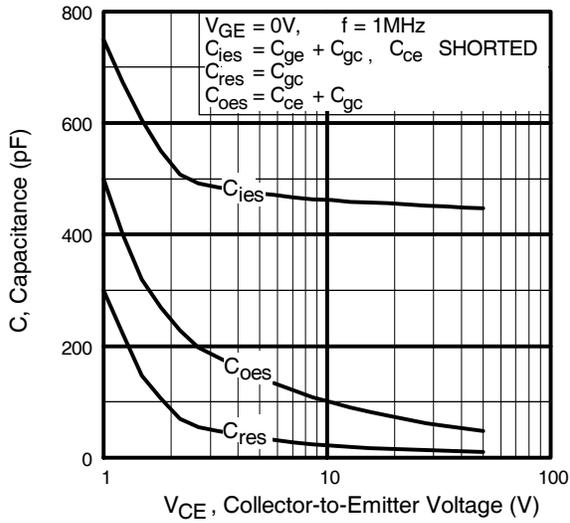


Fig. 7 - Typical Capacitance vs. Collector-to-Emitter Voltage

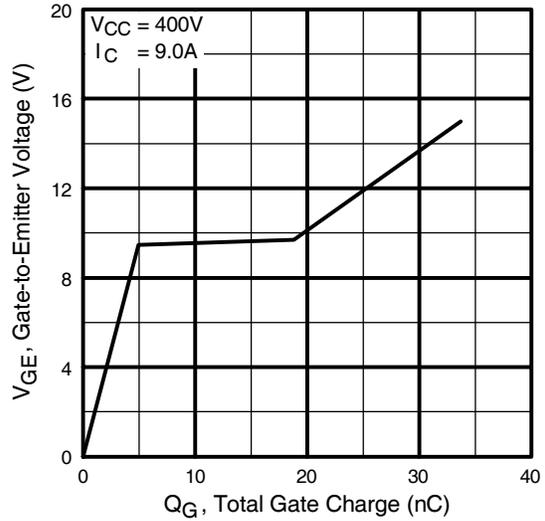


Fig. 8 - Typical Gate Charge vs. Gate-to-Emitter Voltage

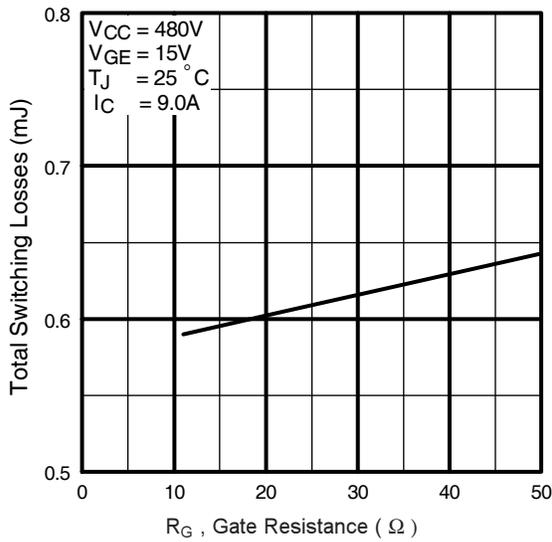


Fig. 9 - Typical Switching Losses vs. Gate Resistance

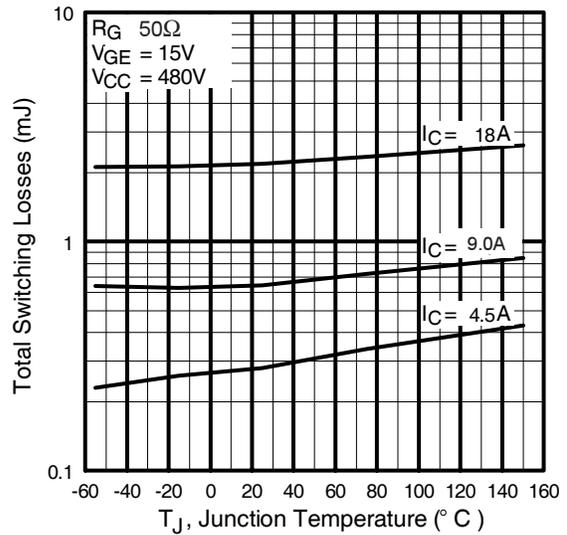


Fig. 10 - Typical Switching Losses vs. Junction Temperature

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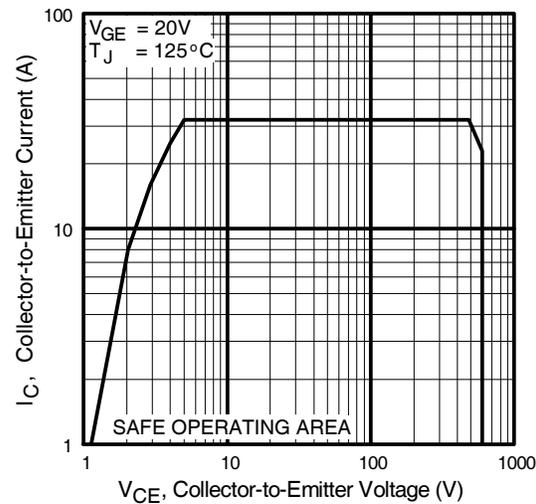
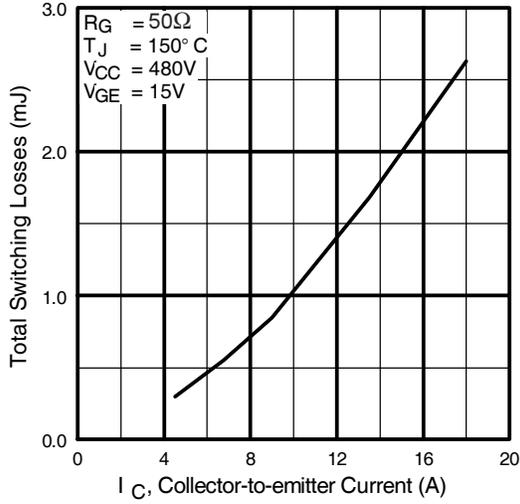


Fig. 11 - Typical Switching Losses vs. Collector-to-emitter Current

Fig. 12 - Turn-Off SOA

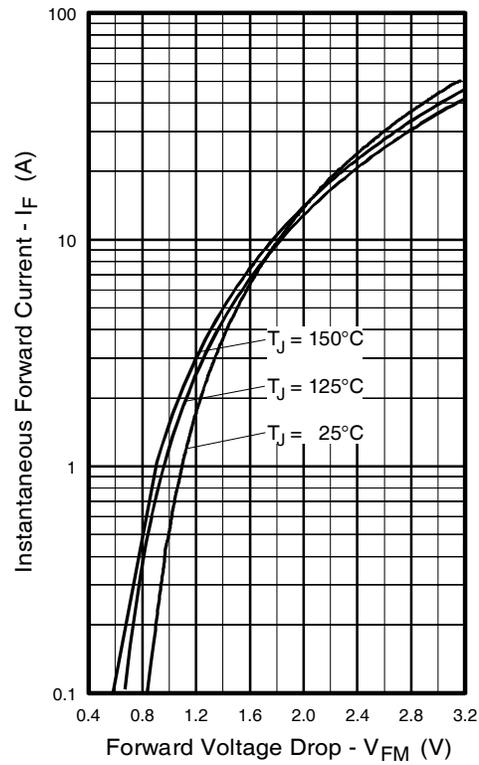


Fig. 13 - Maximum Forward Voltage Drop vs. Instantaneous Forward Current

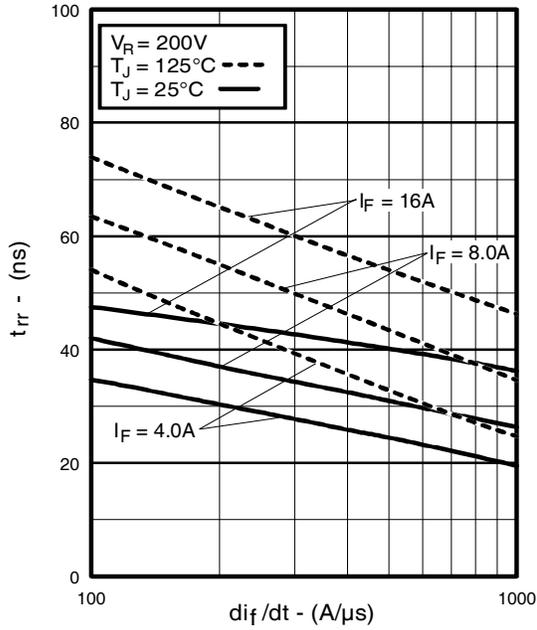


Fig. 14 - Typical Reverse Recovery vs. di_f/dt

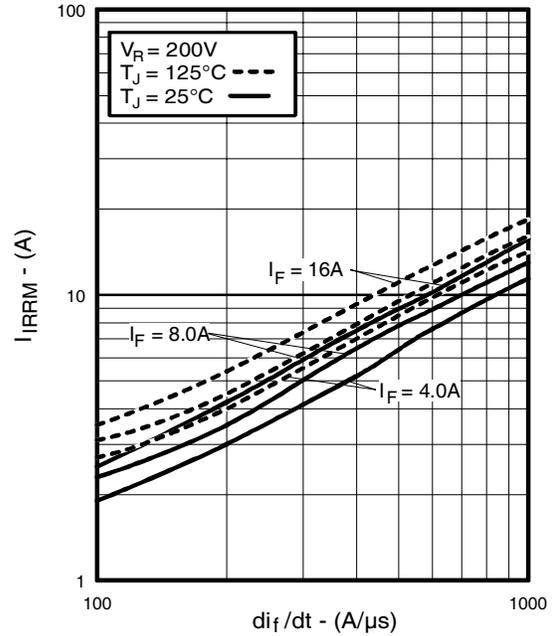


Fig. 15 - Typical Recovery Current vs. di_f/dt

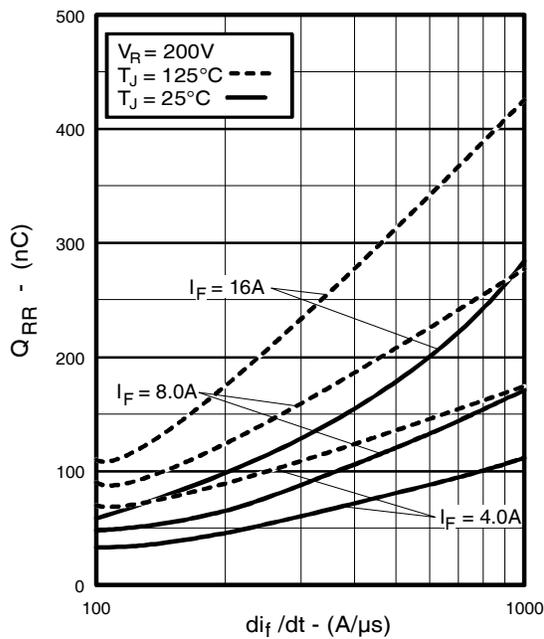


Fig. 16 - Typical Stored Charge vs. di_f/dt

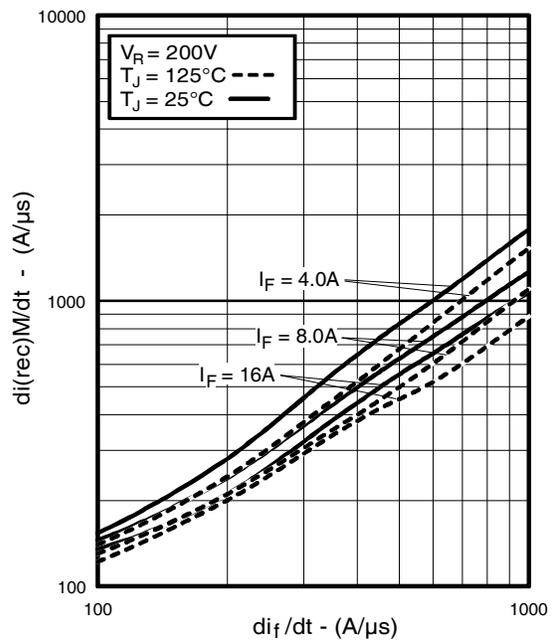


Fig. 17 - Typical $di_{(rec)M}/dt$ vs. di_f/dt

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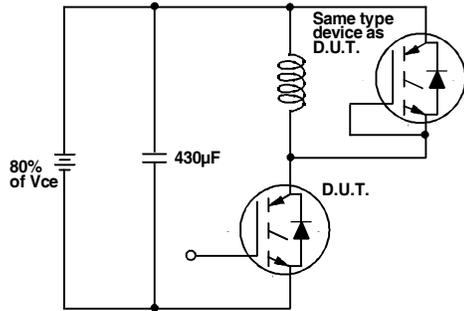


Fig. 18a - Test Circuit for Measurement of I_{LM} , E_{on} , $E_{off}(\text{diode})$, t_{rr} , Q_{rr} , I_{rr} , $t_{d(on)}$, t_r , $t_{d(off)}$, t_f

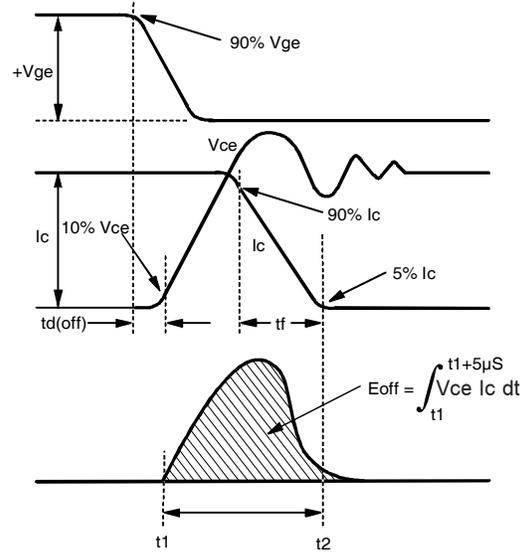


Fig. 18b - Test Waveforms for Circuit of Fig. 18a, Defining E_{off} , $t_{d(off)}$, t_f

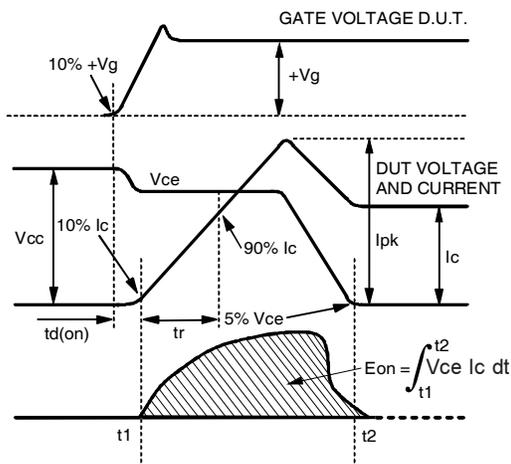


Fig. 18c - Test Waveforms for Circuit of Fig. 18a, Defining E_{on} , $t_{d(on)}$, t_r

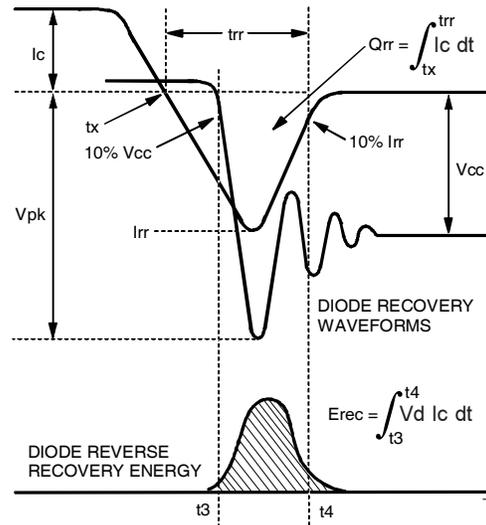
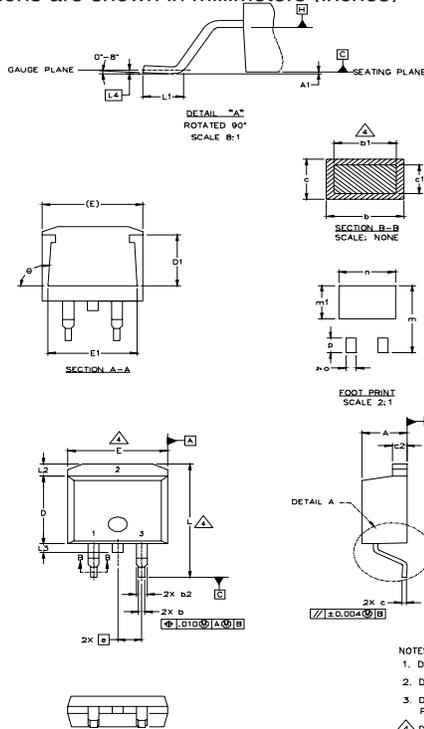


Fig. 18d - Test Waveforms for Circuit of Fig. 18a, Defining E_{rec} , t_{rr} , Q_{rr} , I_{rr}

D²Pak Package Outline

Dimensions are shown in millimeters (inches)



| SYMBOL | DIMENSIONS | | | | NOTES |
|--------|-------------|-------|----------|------|-------|
| | MILLIMETERS | | INCHES | | |
| | MIN. | MAX. | MIN. | MAX. | |
| A | 4.06 | 4.83 | .160 | .190 | 4 |
| A1 | | 0.127 | | .005 | |
| b | 0.51 | 0.99 | .020 | .039 | |
| b1 | 0.51 | 0.89 | .020 | .035 | |
| b2 | 1.14 | 1.40 | .045 | .055 | 4 |
| c | 0.43 | 0.63 | .017 | .025 | |
| c1 | 0.38 | 0.74 | .015 | .029 | 3 |
| c2 | 1.14 | 1.40 | .045 | .055 | |
| D | 8.51 | 9.65 | .335 | .380 | 3 |
| D1 | 5.33 | | .210 | | |
| E | 9.65 | 10.67 | .380 | .420 | 3 |
| E1 | 6.22 | | .245 | | |
| e | 2.54 BSC | | .100 BSC | | |
| L | 14.61 | 15.88 | .575 | .625 | |
| L1 | 1.78 | 2.79 | .070 | .110 | |
| L2 | | 1.65 | | .065 | |
| L3 | 1.27 | 1.78 | .050 | .070 | |
| L4 | 0.25 BSC | | .010 BSC | | |
| m | 17.78 | | .700 | | |
| m1 | 8.89 | | .350 | | |
| n | 11.43 | | .450 | | |
| o | 2.08 | | .082 | | |
| p | 3.81 | | .150 | | |
| θ | 90° | 93° | 90° | 93° | |

LEAD ASSIGNMENTS

| HEXFET | IGBTs, CoPACK | DIODES |
|------------|---------------|-------------|
| 1.- GATE | 1.- GATE | 1.- ANODE * |
| 2.- DRAIN | 2.- COLLECTOR | 2.- CATHODE |
| 3.- SOURCE | 3.- EMITTER | 3.- ANODE |

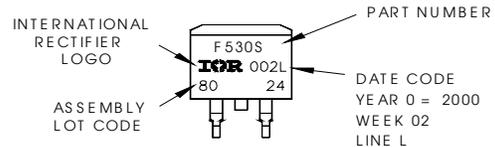
* PART DEPENDENT.

- NOTES:
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
 - DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]
 - DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [0.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
 - DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
 - CONTROLLING DIMENSION: INCH.

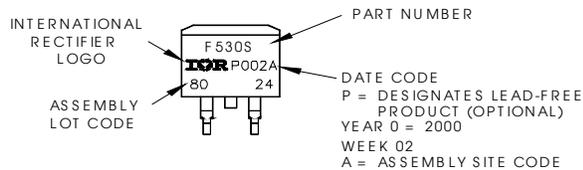
D²Pak Part Marking Information (Lead-Free)

EXAMPLE: THIS IS AN IRF530S WITH
LOT CODE 8024
ASSEMBLED ON WW 02, 2000
IN THE ASSEMBLY LINE "L"

Note: "P" in assembly line
position indicates "Lead-Free"



OR



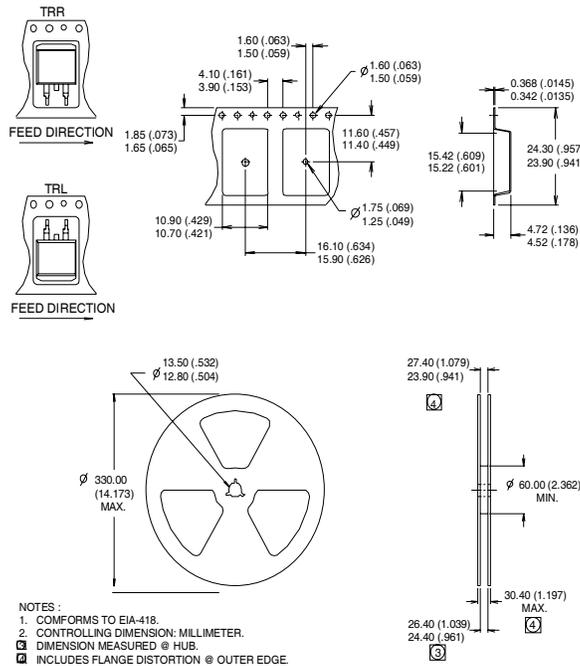
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Notes:

- ① Repetitive rating: $V_{GE}=20V$; pulse width limited by maximum junction temperature (figure 20)
- ② $V_{CC}=80\%(V_{CES})$, $V_{GE}=20V$, $L=10\mu H$, $R_G=50\Omega$ (figure 19)
- ③ Pulse width $\leq 80\mu s$; duty factor $\leq 0.1\%$.
- ④ Pulse width $5.0\mu s$, single shot.
- ⑤ When mounted on 1" square PCB (FR-4 or G-10 Material).
For recommended footprint and soldering techniques refer to application note #AN-994.

D²Pak Tape & Reel Information



Data and specifications subject to change without notice.

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Visit us at www.irf.com for sales contact information.08/04

Note: For the most current drawings please refer to the IR website at:
<http://www.irf.com/package/>



Стандарт Электрон Связь

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Благодаря сотрудничеству с мировыми поставщиками мы осуществляем комплексные и плановые поставки широчайшего спектра электронных компонентов.

Собственная эффективная логистика и склад в обеспечивает надежную поставку продукции в точно указанные сроки по всей России.

Мы осуществляем техническую поддержку нашим клиентам и предпродажную проверку качества продукции. На все поставляемые продукты мы предоставляем гарантию .

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Наши контакты:

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Электронная почта: sales@st-electron.ru

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